

<b>Notice of References Cited</b>	Application/Control No. 10/731,026	Applicant(s)/Patent Under Reexamination HANIBUCHI, TOSHIAKI	
	Examiner Leon Flores	Art Unit 2611	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0043926 A1	03-2003	Terashima et al.	375/257
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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